

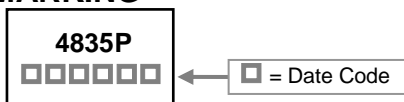
RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

DESCRIPTION

The SSG4835PR-C is the highest performance trench P-ch MOSFETs with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The SSG4835PR-C meet the RoHS and Green Product requirement with full function reliability approved.

MARKING



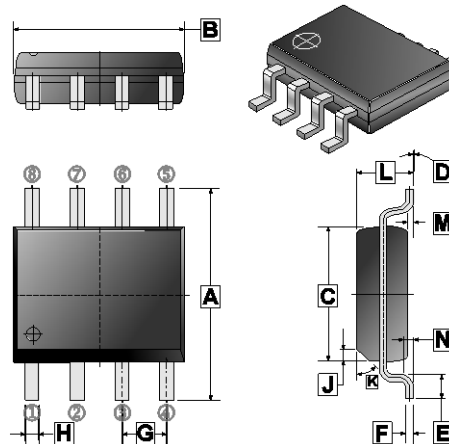
PACKAGE INFORMATION

Package	MPQ	Leader Size
SOP-8	2.5K	13 inch

ORDER INFORMATION

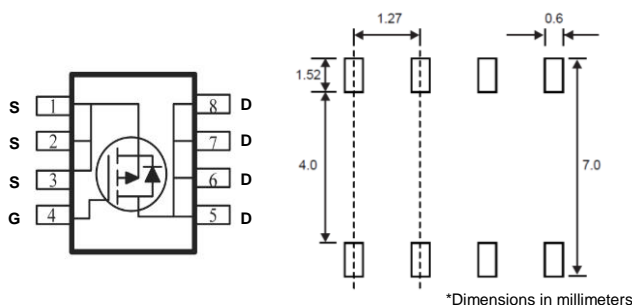
Part Number	Type
SSG4835PR-C	Lead (Pb)-free and Halogen-free

SOP-8



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	5.79	6.20	H	0.33	0.51
B	4.70	5.11	J	0.375 REF.	
C	3.80	4.00	K	45° REF.	
D	0°	8°	L	1.3	1.752
E	0.40	1.27	M	0	0.25
F	0.10	0.25	N	0.25 REF.	
G	1.27 TYP.				

Mounting Pad Layout



MAXIMUM RATINGS

Parameter	Symbol	Ratings	Unit	
Drain-Source Voltage	V_{DS}	-30	V	
Gate-Source Voltage	V_{GS}	± 20	V	
Continuous Drain Current @ $V_{GS}=10V$ ¹	I_D	$T_A=25^\circ C$	-8	A
		$T_A=70^\circ C$	-6	A
Pulsed Drain Current ³	I_{DM}	-50	A	
Total Power Dissipation	P_D	1.5	W	
Operating Junction & Storage Temperature Range	T_J, T_{STG}	-55 ~ 150	$^\circ C$	
Thermal Resistance Ratings				
Maximum Thermal Resistance Junction-Ambient ¹	$R_{\theta JA}$	85	$^\circ C/W$	
Thermal Resistance Junction-Ambient ²		125		
Maximum Thermal Resistance Junction-Case ¹	$R_{\theta JC}$	36		

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions	
Drain-Source Breakdown Voltage	BV_{DSS}	-30	-	-	V	$V_{GS}=0, I_D = -250\mu\text{A}$	
Gate Threshold Voltage	$V_{GS(th)}$	-1	-	-2.5	V	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$	
Gate-Body Leakage	I_{GSS}	-	-	± 100	nA	$V_{DS}=0\text{V}, V_{GS} = \pm 20\text{V}$	
Drain-Source Leakage Current	I_{DSS}	$T_J=25^\circ\text{C}$	-	-	-1	μA	$V_{DS} = -24\text{V}, V_{GS}=0\text{V}$
		$T_J=55^\circ\text{C}$	-	-	-5		
Drain-Source On-Resistance ⁴	$R_{DS(ON)}$	-	-	21	m Ω	$V_{GS} = -10\text{V}, I_D = -6\text{A}$	
		-	-	32		$V_{GS} = -4.5\text{V}, I_D = -4\text{A}$	
Gate Resistance	R_g	-	15	-	Ω	$f=1\text{MHz}$	
Forward Transconductance	g_{fs}	-	17	-	S	$V_{DS} = -5\text{V}, I_D = -6\text{A}$	
Total Gate Charge	Q_g	-	12.6	-	nC	$I_D = -6\text{A}$ $V_{DS} = -15\text{V}$ $V_{GS} = -4.5\text{V}$	
Gate-Source Charge	Q_{gs}	-	4.8	-			
Gate-Drain Charge	Q_{gd}	-	4.8	-			
Turn-On Delay Time	$T_{d(on)}$	-	4.6	-	nS	$V_{DD} = -15\text{V},$ $I_D = -6\text{A}$ $V_{GS} = -10\text{V},$ $R_G = 3.3\Omega$	
Rise Time	T_r	-	14.8	-			
Turn-Off Delay Time	$T_{d(off)}$	-	41	-			
Fall Time	T_f	-	19.6	-			
Input Capacitance	C_{iss}	-	1345	-	pF	$V_{DS} = -15\text{V}$ $V_{GS}=0$ $f=1\text{MHz}$	
Output Capacitance	C_{oss}	-	194	-			
Reverse Transfer Capacitance	C_{rss}	-	158	-			
Source-Drain Diode							
Continuous Source Current ¹	I_S	-	-	-8	A		
Pulsed Source Current ³	I_{SM}	-	-	-50	A		
Diode Forward Voltage ⁴	V_{SD}	-	-	-1.2	V	$V_{GS}=0\text{V}, I_S = -1\text{A}, T_J=25^\circ\text{C}$	
Reverse Recovery Time	t_{rr}	-	16.3	-	nS	$I_F = -6\text{A}, di/dt=100\text{A}/\mu\text{s},$ $T_J=25^\circ\text{C}$	
Reverse Recovery Charge	Q_{rr}	-	5.9	-	nC		

Notes:

- Surface mounted on a 1 inch² FR-4 board with 2oz copper.
- When mounted on Min. copper pad.
- Pulse width limited by maximum junction temperature, Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$.
- The data tested by pulsed, pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

CHARACTERISTIC CURVES

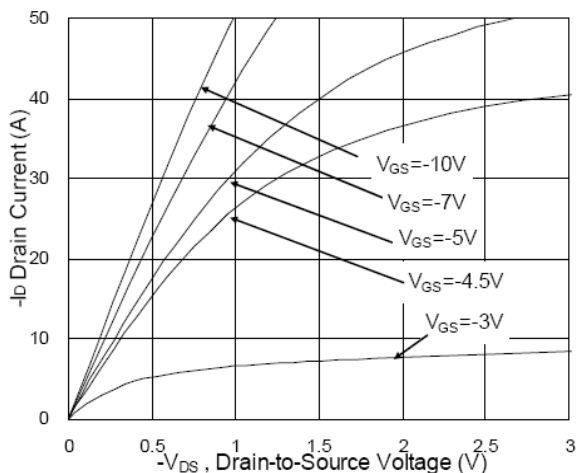


Fig.1 Typical Output Characteristics

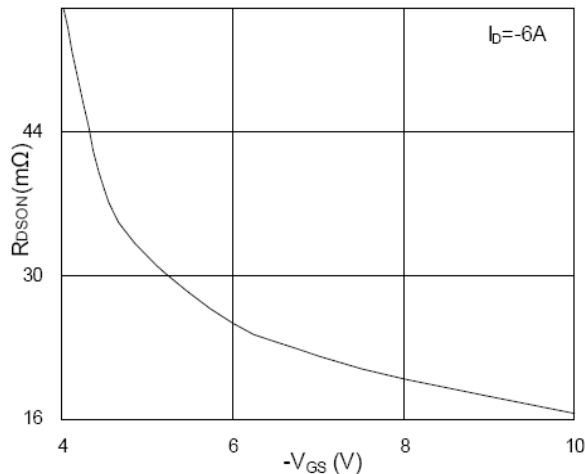


Fig.2 On-Resistance v.s Gate-Source

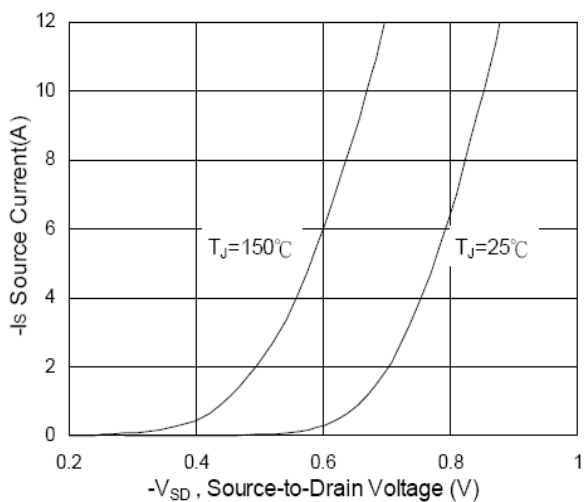


Fig.3 Forward Characteristics of Reverse

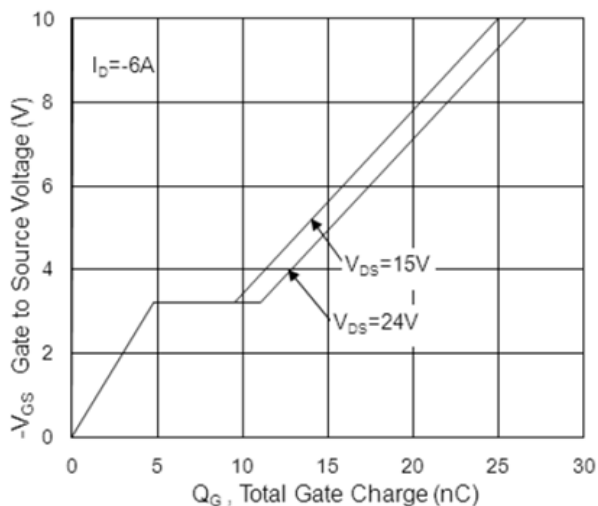


Fig.4 Gate-Charge Characteristics

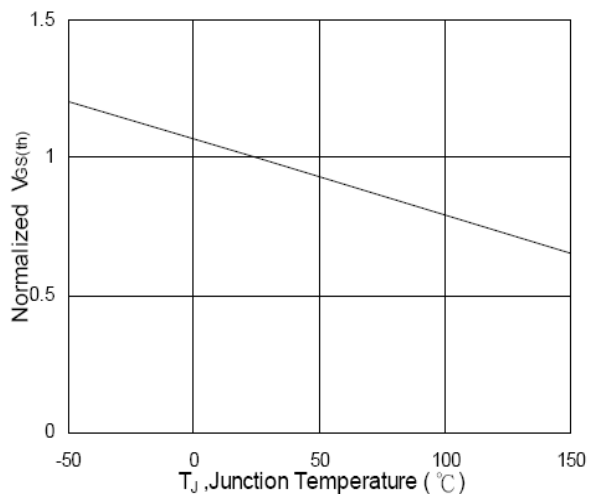


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

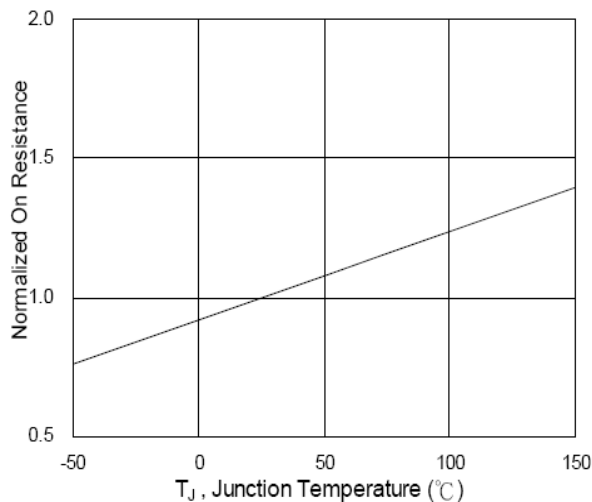


Fig.6 Normalized $R_{DS(ON)}$ vs. T_J

CHARACTERISTIC CURVES

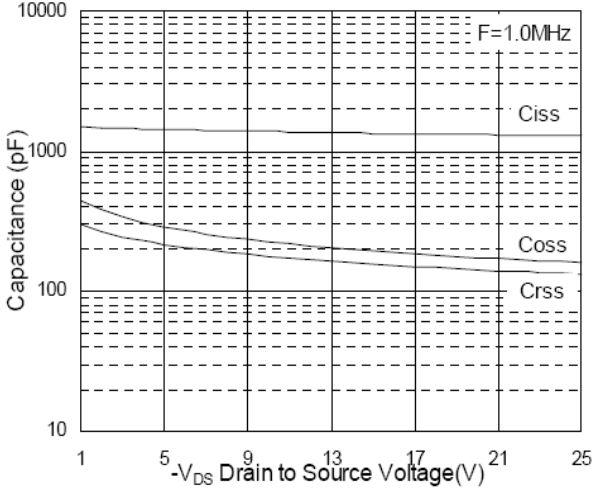


Fig.7 Capacitance

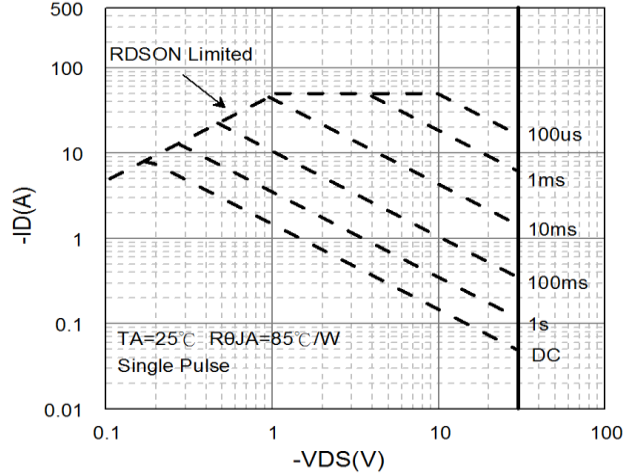


Fig.8 Safe Operating Area

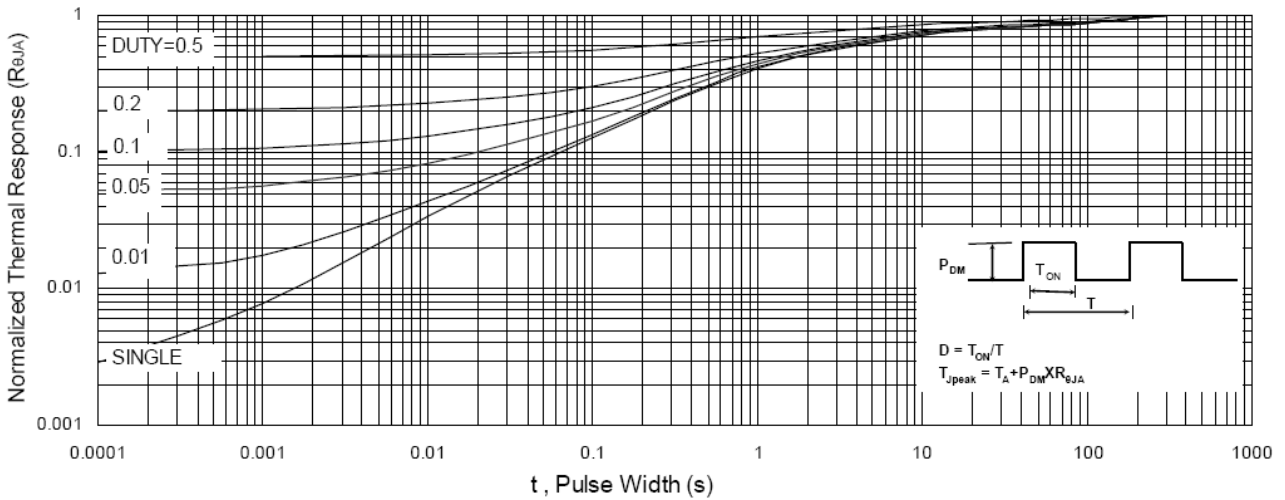


Fig.9 Normalized Maximum Transient Thermal Impedance

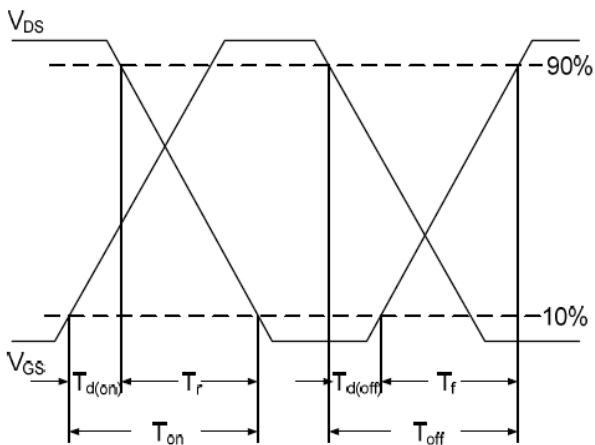


Fig.10 Switching Time Waveform

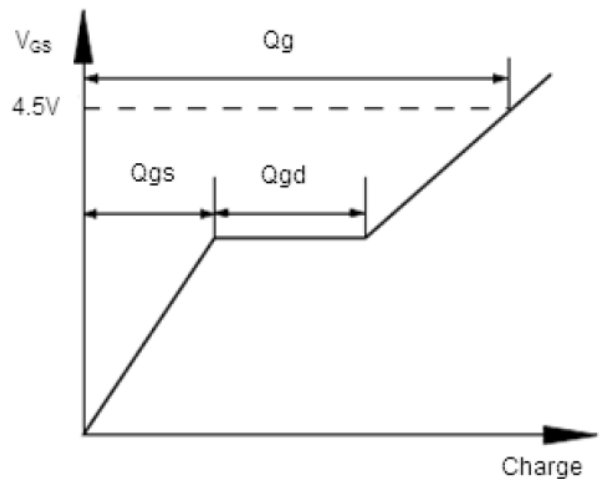


Fig.11 Gate Charge Waveform